

# 100 MIPS, 64 kB Flash, 10-Bit ADC, 100-Pin Mixed-Signal MCU

# Analog Peripherals 10-Bit ADC

- ±1 LSB INL; no missing codes
- Programmable throughput up to 100 ksps
- 8 external inputs; programmable as single-ended or differential
- Programmable amplifier gain: 16, 8, 4, 2, 1, 0.5
- Data-dependent windowed interrupt generator
- Built-in temperature sensor (±3 °C)

### **Two Comparators**

### Internal Voltage Reference

V<sub>DD</sub> Monitor/Brown-out Detector

# On-Chip JTAG Debug & Boundary Scan

- On-chip debug circuitry facilitates full speed, non-intrusive in-system debug (no emulator required)
- Provides breakpoints, single stepping, watchpoints, stack monitor
- Inspect/modify memory and registers
- Superior performance to emulation systems using ICE-chips, target pods, and sockets
- IEEE1149.1 compliant boundary scan

# High-Speed 8051 µC Core

- Pipelined instruction architecture; executes 70% of instructions in 1 or 2 system clocks
- Up to 100 MIPS throughput with 100 MHz system clock
- 16 x 16 multiply/accumulate engine (2-cycle)

### Memory

- 8448 bytes data RAM
- 64 kB Flash; in-system programmable in 1024-byte sectors (1024 bytes are reserved)
- External parallel data memory interface

### **Digital Peripherals**

- 64 port I/O; all are 5 V tolerant
- Hardware SMBus™ (I2C™ compatible), SPI™, and two UART serial ports available concurrently
- Programmable 16-bit counter/timer array with six capture/compare modules
- 5 general-purpose 16-bit counter/timers
- Dedicated watchdog timer; bidirectional reset
- Real-time clock mode using timer 3 or PCA

#### **Clock Sources**

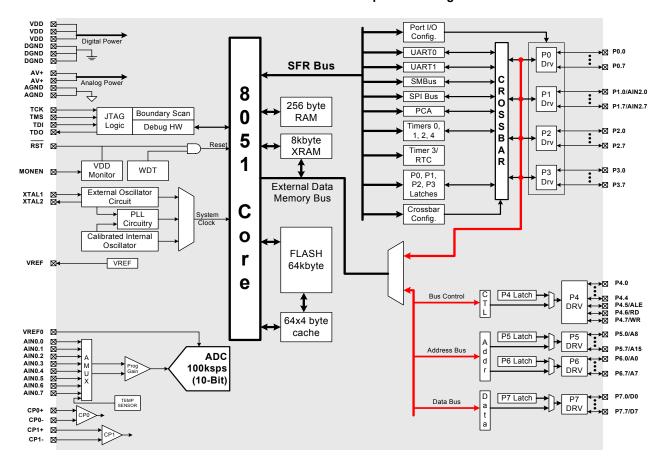
- Internal oscillator: 24.5 MHz, 2% accuracy supports UART operation
- On-chip programmable PLL: up to 100 MHz
- External oscillator: Crystal, RC, C, or Clock

### Supply Voltage: 3.0 to 3.6 V

- Typical operating current: 50 mA at 100 MHz
- Typical stop mode current: 0.4 μA

#### 100-Pin TQFP

Temperature Range: -40 to +85 °C





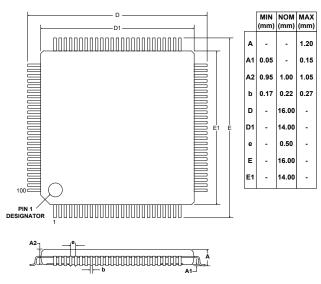
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# **Selected Electrical Specifications**

 $(T_A = -40 \text{ to } +85 \text{ C}^{\circ}, V_{DD} = 3.0 \text{ V} \text{ unless otherwise specified})$ 

PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
GLOBAL CHARACTERIST	TICS				
Supply Voltage		3.0	_	3.6	V
Supply Current	Clock = 100 MHz	_	50	_	mA
(CPU active)	Clock = 1 MHz	_	0.6	_	mA
	Clock = 32 kHz	_	16	_	μΑ
Supply Current	Oscillator off; V <sub>DD</sub> Monitor Enabled	_	10	_	μA
(shutdown)	Oscillator off; V <sub>DD</sub> Monitor Disabled	_	0.4	_	μA
Clock Frequency Range		DC	_	100	MHz
INTERNAL CLOCKS					
Oscillator Frequency		24.0	24.5	25.0	MHz
PLL Frequency		_	_	100	MHz
A/D CONVERTER					
Resolution			10		bits
Integral Nonlinearity		_	_	±1	LSB
Differential Nonlinearity	Guaranteed Monotonic	_	_	±1	LSB
Signal-to-Noise Plus		59	_	_	dB
Distortion					
Throughput Rate			_	100	ksps

# **Package Information**



# C8051F120DK Development Kit

